

<b>Notice of References Cited</b>	Application/Control No. 09/856,858	Applicant(s)/Patent Under Reexamination BAYON ET AL.	
	Examiner Sheridan K Snedden	Art Unit 1653	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,808,113	04-1974	Okamura et al.	427/493
	B	US-5,733,337	03-1998	Carr et al.	435/325
	C	US-6,391,939	05-2002	Tayot et al.	523/105
	D	US-5,035,715	07-1991	Smestad et al.	424/423
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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